

HIGH-VOLTAGE OPTOCOUPLER

Optically coupled isolator consisting of an infrared emitting GaAs diode and a silicon n-p-n photo-transistor. The base is not accessible.

Features of this product:

- very high isolation voltage of 10 kV (d.c.).
- working voltage of 10 kV (d.c.).
- high common mode rejection 85 dB

QUICK REFERENCE DATA

Diode

Continuous reverse voltage	V_R	max.	5 V
Forward current d.c. (peak value); $t_p = 10 \mu s$; $\delta = 0,01$	I_F I_{FRM}	max.	50 mA 3 A
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	P_{tot}	max.	100 mW

Transistor

Collector-emitter voltage (open base)	V_{CEO}	max.	30 V
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	P_{tot}	max.	100 mW

Optocoupler

Output/input d.c. current transfer ratio (C.T.R.) $I_F = 10 \text{ mA}$; $V_{CE} = 0,4 \text{ V}$; ($I_B = 0$)	I_C/I_F	>	0,2
Collector cut-off current (dark) $V_{CC} = 10 \text{ V}$; working voltage (d.c.) = 10 kV diode: $I_F = 0$ (see also Fig. 4)	I_{CEW}	<	200 nA
Isolation voltage (d.c.)	V_{IORM}	min.	10 kV

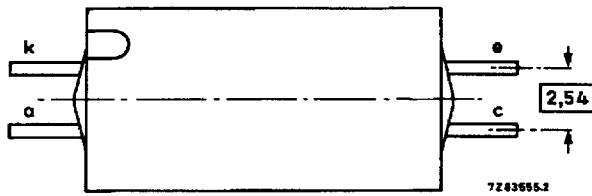
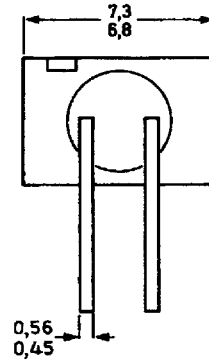
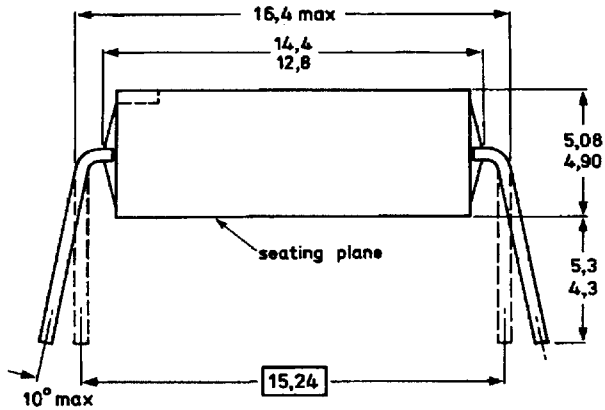
MECHANICAL DATA

SOT-211 (see Fig. 1)

MECHANICAL DATA

Fig. 1 SOT-211.

Dimensions in mm



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Diode

Continuous reverse voltage	V_R	max.	5 V
Forward current	I_F	max.	50 mA
d.c.	I_{FRM}	max.	3 A
(peak value); $t_p = 10 \mu s$; $\delta = 0,01$	P_{tot}	max.	100 mW
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$			

Transistor

Collector-emitter voltage (open base)	V_{CEO}	max.	30 V
Emitter-collector voltage (open base)	V_{ECO}	max.	7 V
Collector current	I_C	max.	25 mA
d.c.	I_{CM}	max.	50 mA
peak value	P_{tot}	max.	100 mW
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$			

Optocoupler

Storage temperature	T_{stg}	-55 to + 100 °C
Junction temperature	T_j	max. 100 °C
Lead soldering temperature up to the seating plane; $t_{sld} < 10$ s	T_{sld}	max. 260 °C

THERMAL RESISTANCE

From junction to ambient in free air diode	$R_{th\ j-a}$	max. 750 K/W
transistor	$R_{th\ j-a}$	max. 750 K/W
From junction to ambient, device mounted on a printed circuit board diode	$R_{th\ j-a}$	max. 400 K/W
transistor	$R_{th\ j-a}$	max. 400 K/W

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Diode

Forward voltage $I_F = 10$ mA	V_F	typ. 1,15 V < 1,3 V
Reverse current $V_R = 5$ V	I_R	< 100 μ A
Diode capacitance at $f = 1$ MHz $V_R = 0$	C_d	typ. 40 pF

Transistor

Collector cut-off current (dark) $V_{CE} = 10$ V	I_{CEO}	typ. 2 nA < 50 nA
Collector-emitter breakdown voltage open base; $I_C = 1$ mA	$V_{(BR)CEO}$	min. 30 V
Emitter-collector breakdown voltage open base; $I_E = 0,1$ mA	$V_{(BR)ECO}$	min. 7 V

Optocoupler ($I_B = 0$)*

Output/input d.c. current transfer ratio (C.T.R.) $I_F = 10$ mA; $V_{CE} = 0,4$ V	I_C/I_F	min. 0,2 typ. 0,5
Collector-emitter saturation voltage $I_F = 10$ mA; $I_C = 2$ mA	V_{CEsat}	typ. 0,15 V
Isolation voltage, d.c. value (see note 1)	V_{IORM}	min. 10 kV

Note see next page.

* Where the phototransistor receives light from the diode the O (for open base) has been omitted from the symbols.

Capacitance between input and output

$I_F = 0; V = 0; f = 1 \text{ MHz}$

C_{IO} typ. 0,15 pF

Insulation resistance between input and output

$\pm V_{IO} = 1 \text{ kV}$

r_{IO} > $10^{11} \Omega$
 $12^{12} \Omega$

Common mode rejection (see Fig. 3)

$I_C = 2 \text{ mA}; f = 10 \text{ kHz}$

CMRR typ. 85 dB

Switching times (see Fig. 13)

$I_{Con} = 2 \text{ mA}; V_{CC} = 5 \text{ V}; R_L = 100 \Omega$

Turn-on time

t_{on} typ. 3 μs

Turn-off time

t_{off} typ. 3 μs

$I_{Con} = 2 \text{ mA}; V_{CC} = 5 \text{ V}; R_L = 1 \text{ k}\Omega$

Turn-on time

t_{on} typ. 12 μs

Turn-off time

t_{off} typ. 12,5 μs

Collector cut-off current (dark) see Fig. 2

$V_{CC} = 10 \text{ V};$ working voltage (d.c.) = 10 kV

$I_{CEW} < 200 \text{ nA}^*$

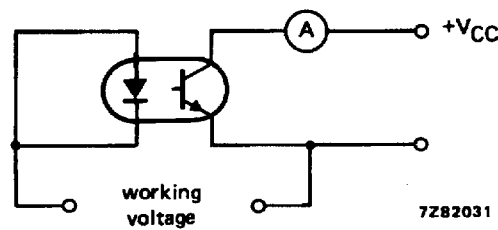


Fig. 2.

Notes

1. This parameter is tested with both input (diode) leads shorted together and both output (photo-transistor) leads shorted together at 10 kV (d.c.) for 1 min. Tested on sample basis.

2. $CMRR = \frac{V_o}{V_{CM}}$

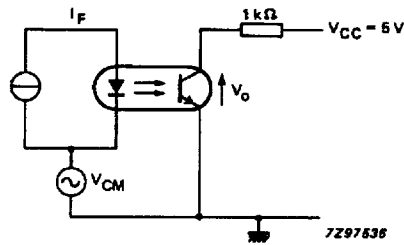


Fig. 3.

* As quality assurance (on a sample basis), these parameters are covered by a 1000 h reliability test.

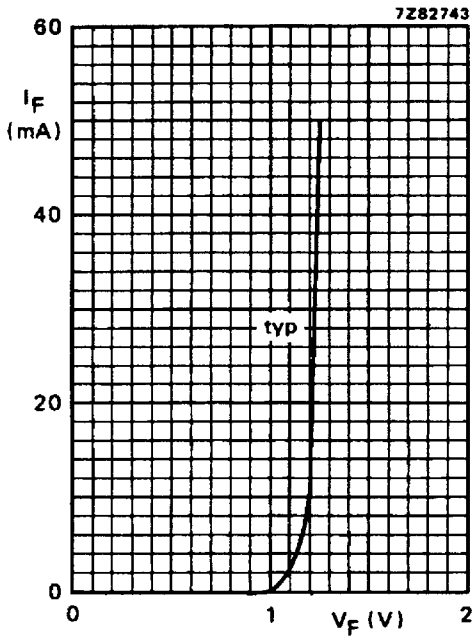


Fig. 4 $T_j = 25\text{ }^\circ\text{C}$.

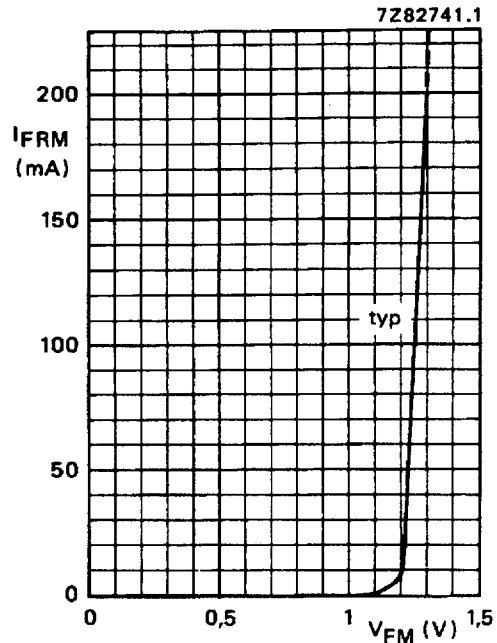


Fig. 5 $T_{amb} = 25\text{ }^\circ\text{C}$; $t_p = 10\text{ }\mu\text{s}$; $T = 1\text{ ms}$.

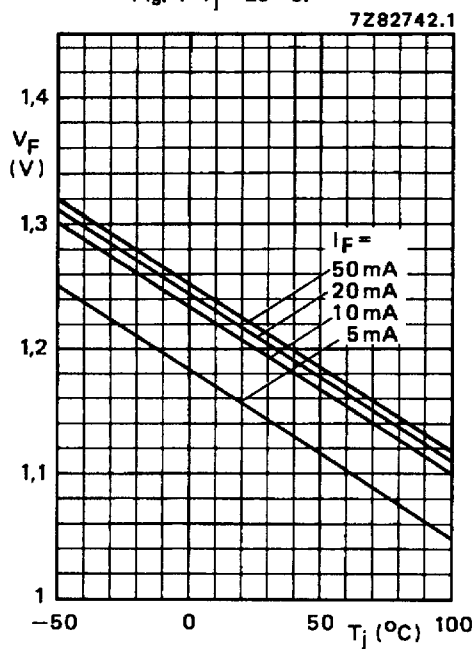


Fig. 6 Typical values.

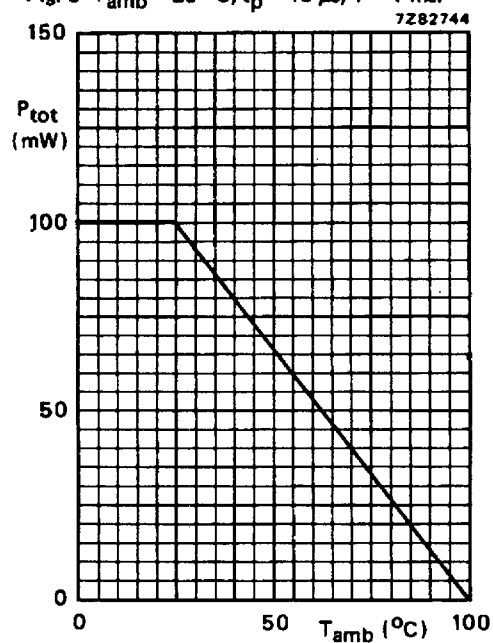


Fig. 7 Power derating curve for diode and transistor versus ambient temperature.

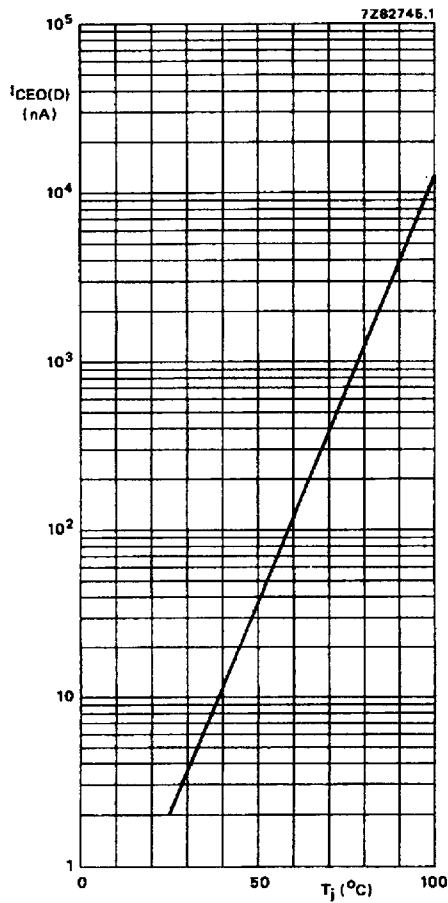


Fig. 8 Typical values.

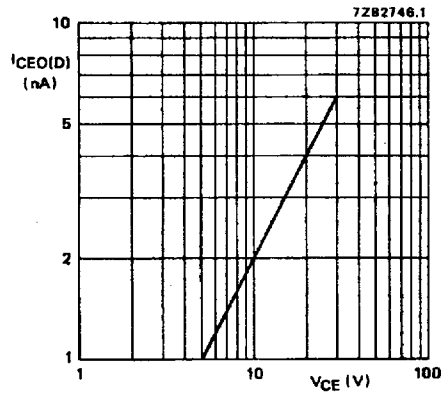


Fig. 9 Typical values.

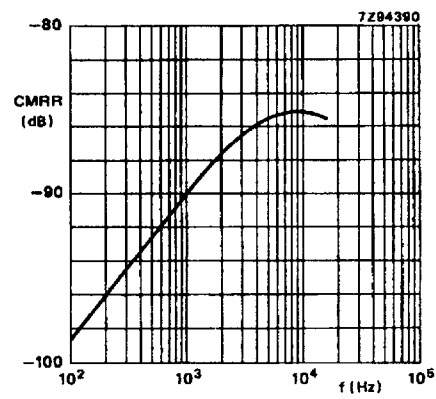


Fig. 10 Typical values.

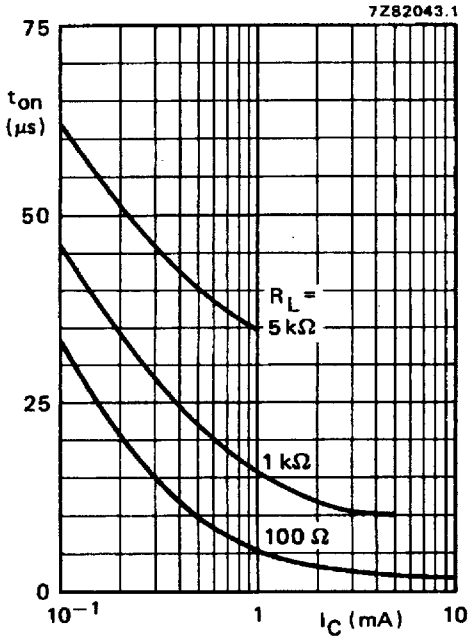


Fig. 11 $I_B = 0$; $V_{CC} = 5\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; typical values. See also Fig. 13.

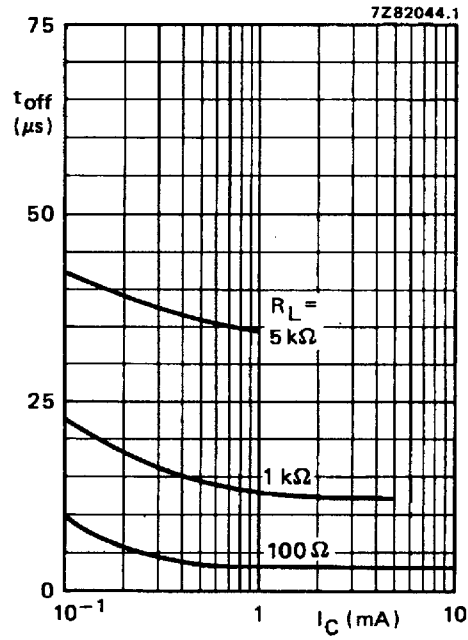


Fig. 12 $I_B = 0$; $V_{CC} = 5\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; typical values. See also Fig. 13.

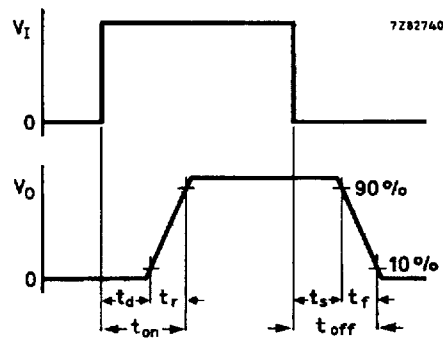
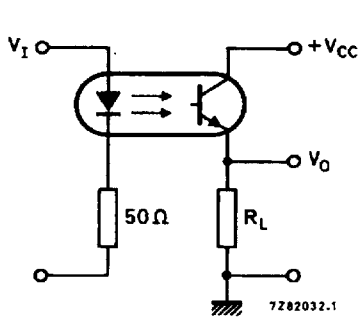


Fig. 13 Switching circuit and waveforms.